Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/665,053	BYBEE ET AL.
Examiner	Art Unit

Rachel Dicht

2853

	SEARCHED						
Class	Subclass	Date	Examiner				
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	')
	DATE	EXMR
See updated seach notes	11/1/2005	RSD
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